

UTT36N10H

Power MOSFET

36A, 100V N-CHANNEL
POWER MOSFET

■ DESCRIPTION

The UTC **UTT36N10H** is a N-channel mode power MOSFET using UTC's advanced technology to provide customers with a minimum on-state resistance, low gate charge and high switching speed.

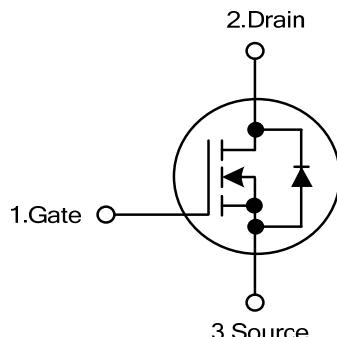
The UTC **UTT36N10H** is suitable for high voltage synchronous rectifier and DC/DC converters, etc.

■ FEATURES

* $R_{DS(ON)} \leq 44 \text{ m}\Omega$ @ $V_{GS}=10\text{V}$, $I_D=30\text{A}$

* High Switching Speed

■ SYMBOL



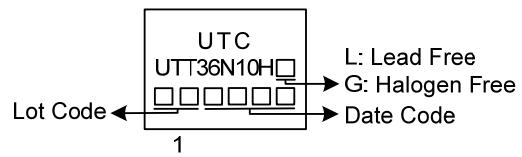
■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
UTT36N10HL-TA3-T	UTT36N10HG-TA3-T	TO-220	G	D	S	Tube
UTT36N10HL-TM3-T	UTT36N10HG-TM3-T	TO-251	G	D	S	Tube
UTT36N10HL-TN3-R	UTT36N10HG-TN3-R	TO-252	G	D	S	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

 UTT36N10HG-TA3-T	(1) Packing Type			(1) T: Tube, R: Tape Reel		
	(2) Package Type			(2) TA3: TO-220, TM3: TO-251, TN3: TO-252		
	(3) Green Package			(3) G: Halogen Free and Lead Free, L: Lead Free		

■ MARKING



■ ABSOLUTE MAXIMUM RATINGS ($T_c=25^\circ\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	100	V
Gate-Source Voltage		V_{GSS}	± 20	V
Drain Current	Continuous ($V_{GS}=10\text{V}$) $T_c=25^\circ\text{C}$	I_D	36	A
	Pulsed	I_{DM}	72	A
Avalanche Energy (Note 3)	Single Pulsed	E_{AS}	70	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	3.7	V/ns
Power Dissipation	TO-220	P_D	90	W
	TO-251/TO-252		44	W
Junction Temperature		T_J	+150	$^\circ\text{C}$
Storage Temperature		T_{STG}	-55 ~ +150	$^\circ\text{C}$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. $L=0.1\text{mH}$, $I_{AS}=37.4\text{A}$, $V_{DD}=50\text{V}$, $R_G=25\Omega$, Starting $T_J=25^\circ\text{C}$.

4. $I_{SD} \leq 30\text{A}$, $di/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J=25^\circ\text{C}$.

■ THERMAL DATA

PARAMETER		SYMBOL	RATING	UNIT
Junction to Ambient	TO-220	θ_{JA}	62.5	$^\circ\text{C/W}$
	TO-251/TO-252		110	$^\circ\text{C/W}$
Junction to Case	TO-220	θ_{JC}	1.38	$^\circ\text{C/W}$
	TO-251/TO-252		2.85	$^\circ\text{C/W}$

Note: The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

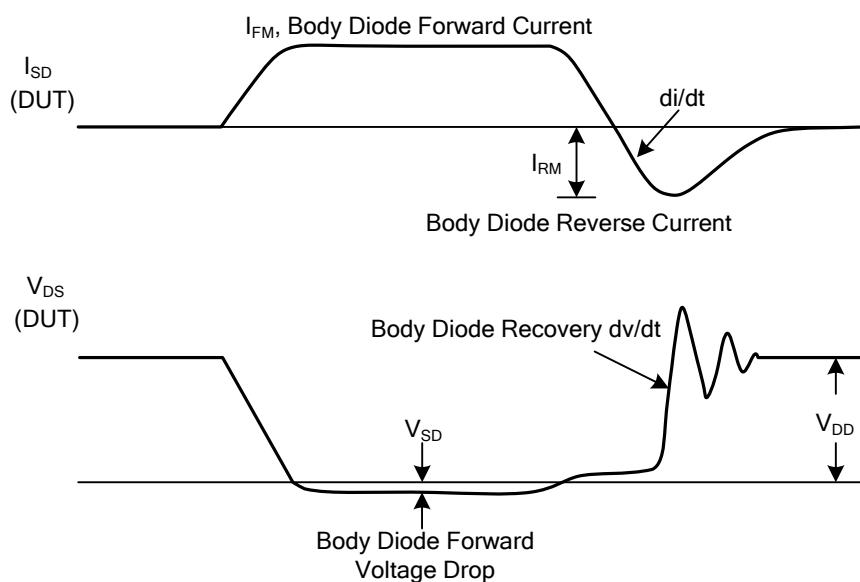
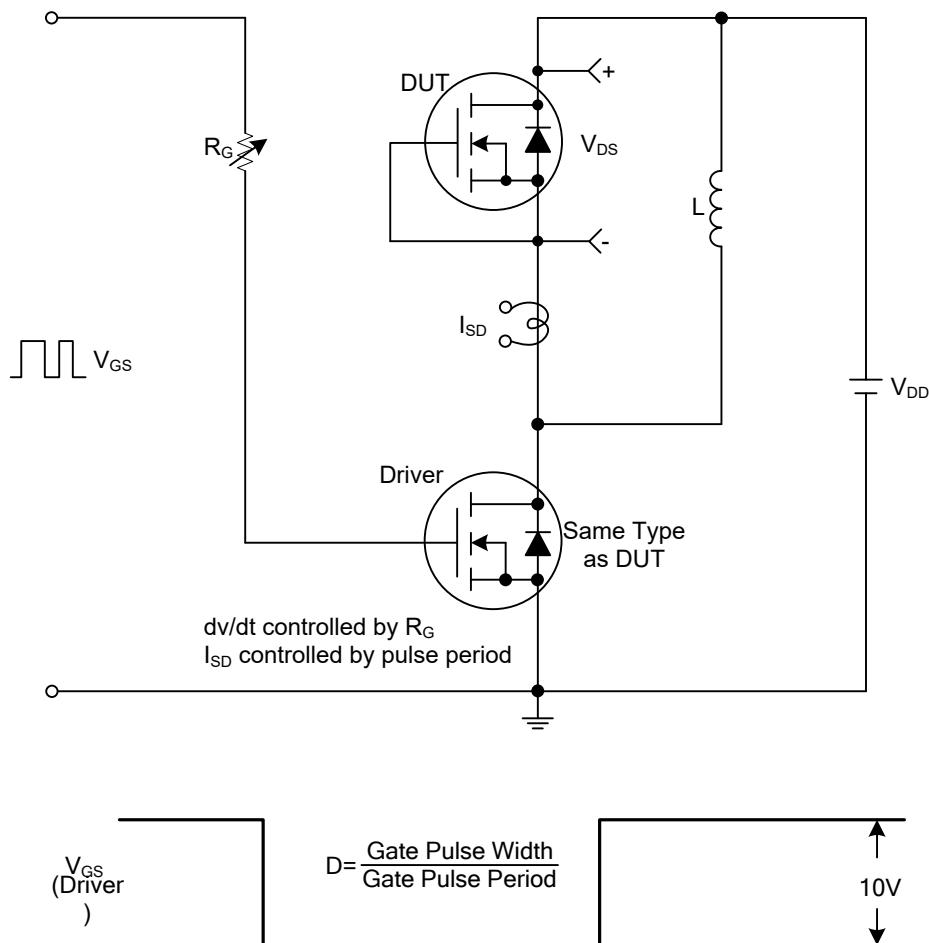
■ ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	100			V
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=100\text{V}, V_{GS}=0\text{V}$			1	μA
Gate- Source Leakage Current	Forward	$V_{GS}=+20\text{V}, V_{DS}=0\text{V}$			+100	nA
	Reverse	$V_{GS}=-20\text{V}, V_{DS}=0\text{V}$			-100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(\text{TH})}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.85		2.55	V
Static Drain-Source On-State Resistance	$R_{DS(\text{ON})}$	$V_{GS}=10\text{V}, I_D=30\text{A}$			44	$\text{m}\Omega$
DYNAMIC PARAMETERS						
Input Capacitance	C_{ISS}	$V_{GS}=0\text{V}, V_{DS}=25\text{V}, f=1.0\text{MHz}$		2860		pF
Output Capacitance	C_{OSS}			144		pF
Reverse Transfer Capacitance	C_{RSS}			125		pF
SWITCHING PARAMETERS						
Total Gate Charge at 10V	Q_G	$V_{DS}=80\text{V}, V_{GS}=10\text{V}, I_D=36\text{A}, I_G=1\text{mA}$ (Note 1, 2)		64		nC
Gate to Source Charge	Q_{GS}			10		nC
Gate to Drain Charge	Q_{GD}			16.5		nC
Turn-ON Time	t_{ON}	$V_{DD}=50\text{V}, V_{GS}=10\text{V}, I_D=36\text{A}, R_G=3.3\Omega$ (Note 1, 2)		11		ns
Turn-ON Delay Time	$t_{D(\text{ON})}$			18		ns
Rise Time	t_R			42		ns
Turn-OFF Delay Time	$t_{D(\text{OFF})}$			19		ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS						
Maximum Body-Diode Continuous Current	I_S				36	A
Continuous Drain-Source Current	I_{SD}				72	A
Drain-Source Diode Forward Voltage	V_{SD}	$I_S=36\text{A}, V_{GS}=0\text{V}$			1.4	V
Reverse Recovery Time	t_{rr}	$I_F=30\text{A}, di/dt = 100\text{A}/\mu\text{s}$		66		ns
Reverse Recovery Charge	Q_{rr}			0.36		μC

Notes: 1. Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$.

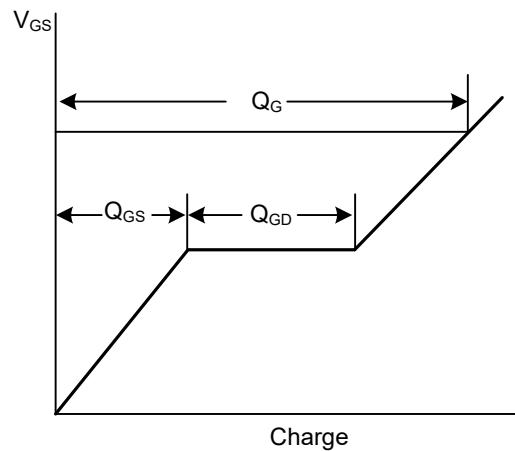
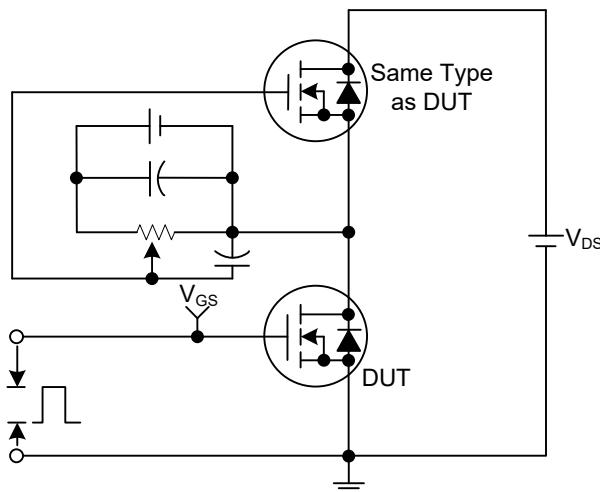
2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

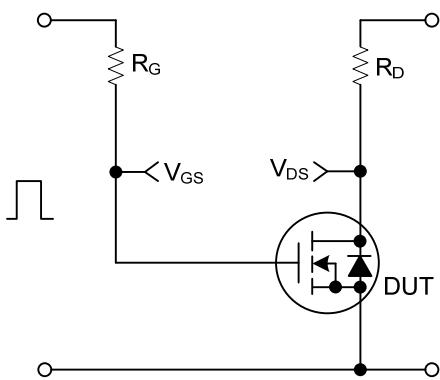


Peak Diode Recovery dv/dt Test Circuit and Waveforms

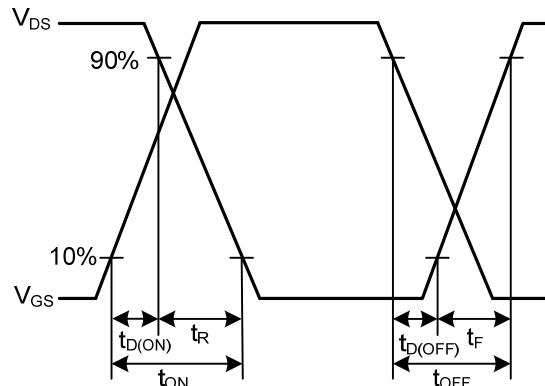
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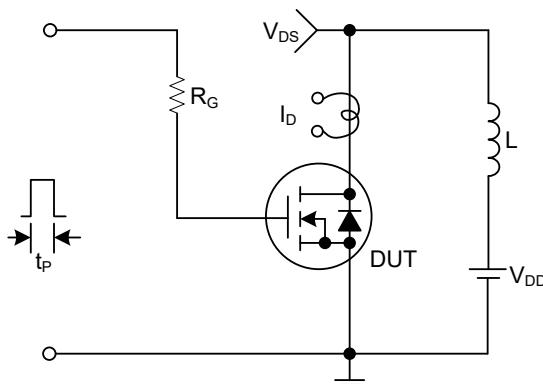
Gate Charge Test Circuit



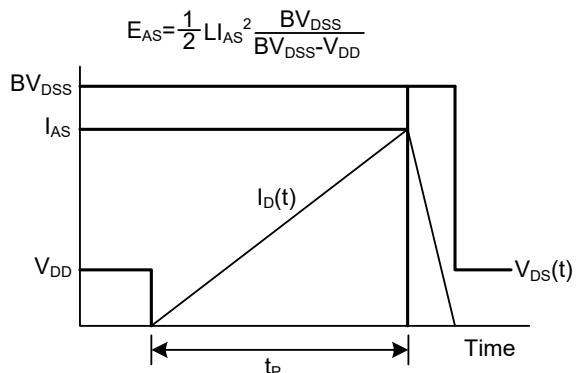
Gate Charge Waveforms



Resistive Switching Test Circuit



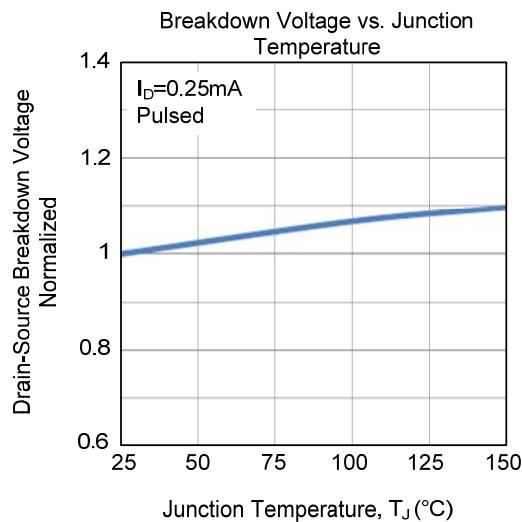
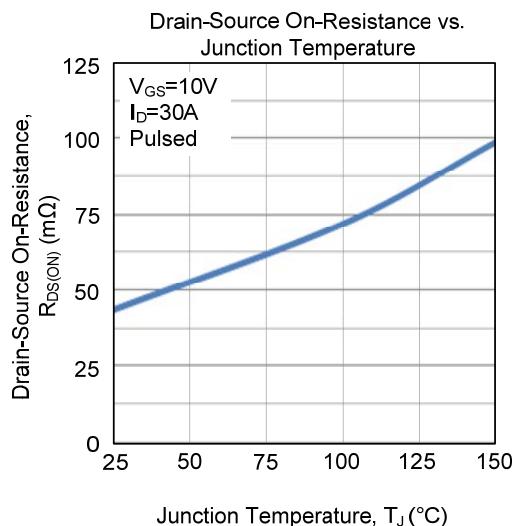
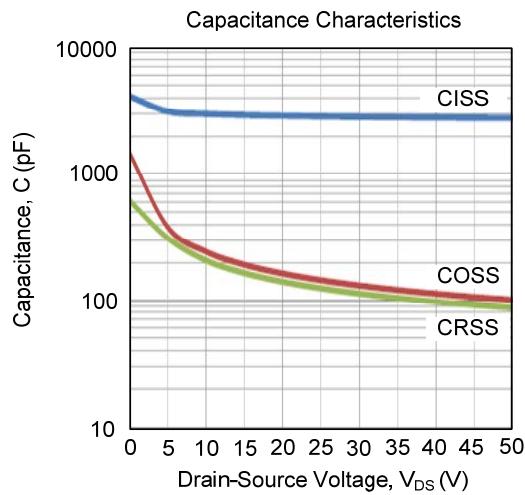
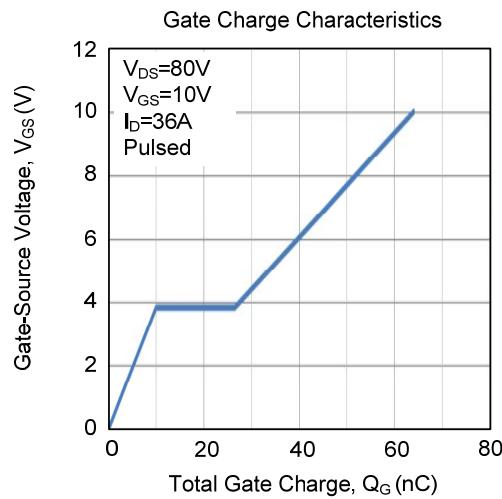
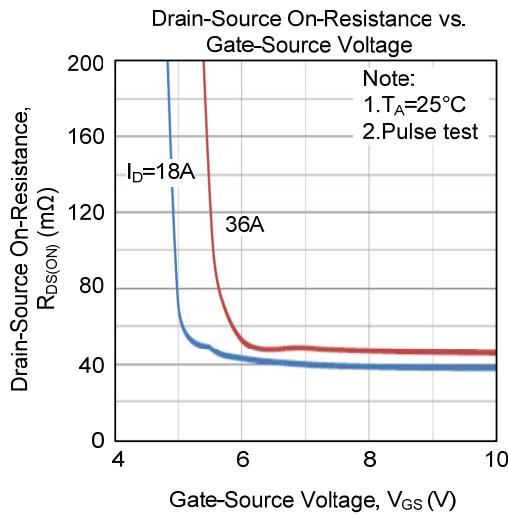
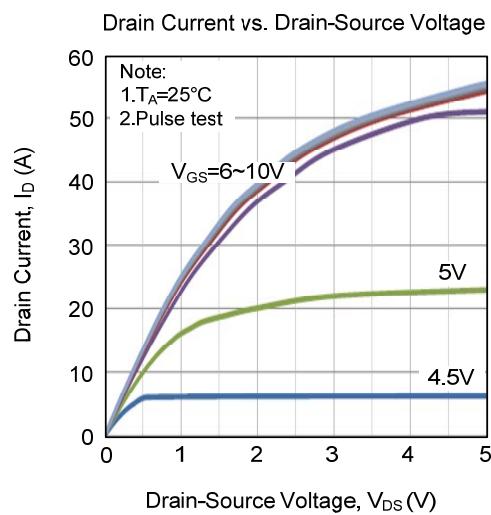
Resistive Switching Waveforms



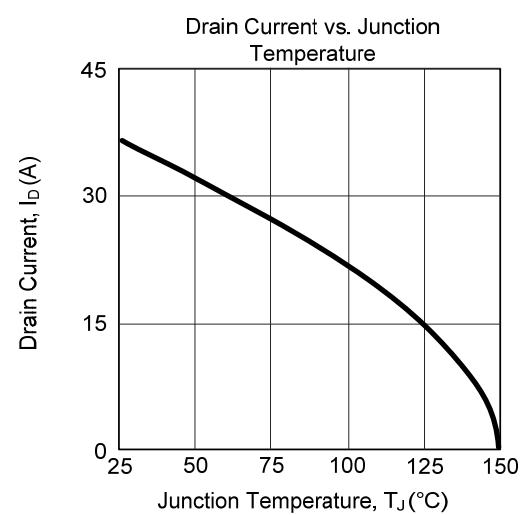
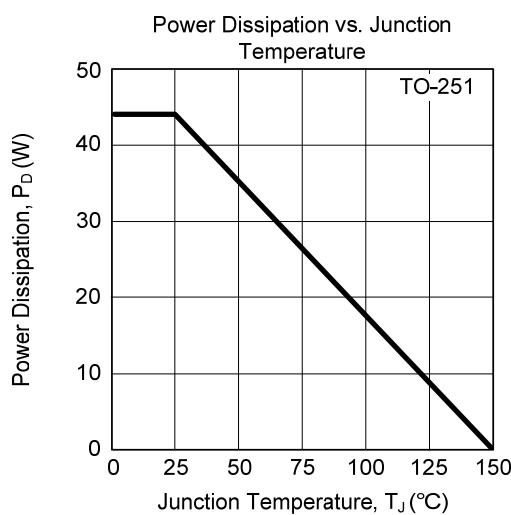
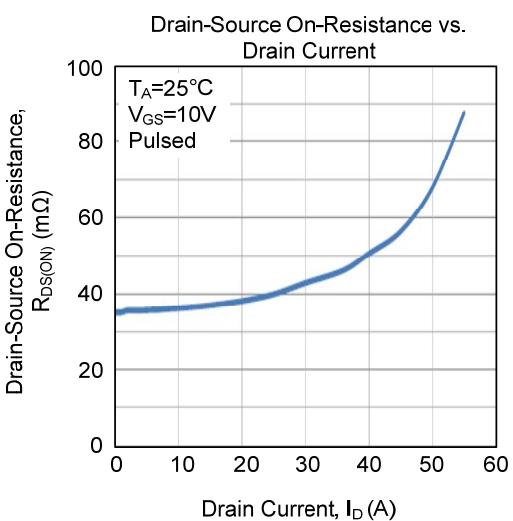
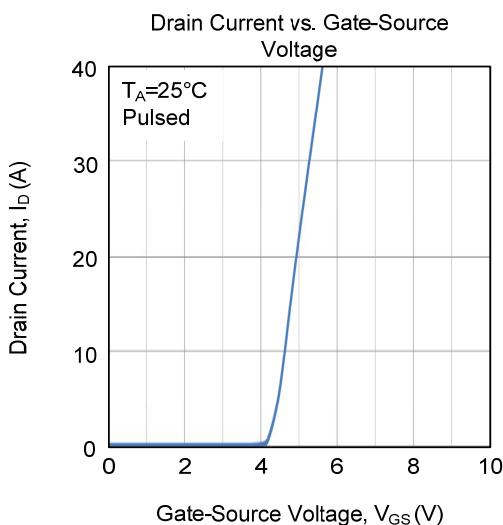
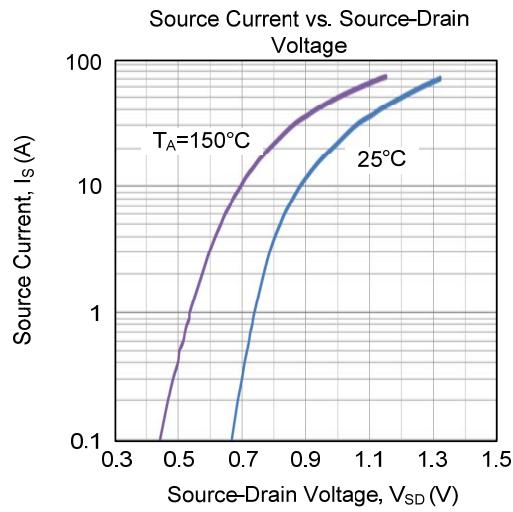
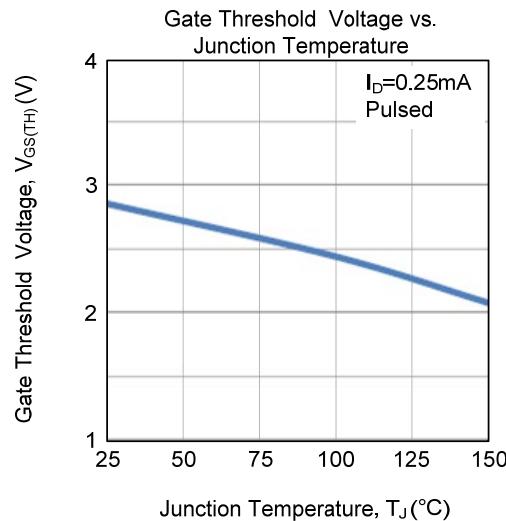
Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

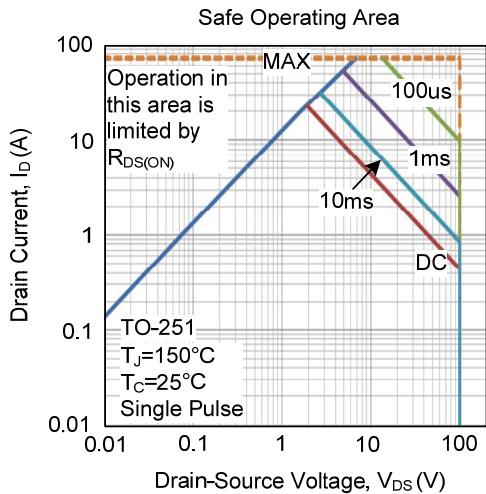
■ TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS (Cont.)



■ TYPICAL CHARACTERISTICS (Cont.)



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